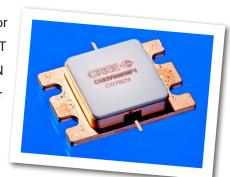


# CGHV96050F1

## 50 W, 7.9 - 9.6 GHz, 50-ohm, Input/Output Matched GaN HEMT

Cree's CGHV96050F1 is a gallium nitride (GaN) High Electron Mobility Transistor (HEMT) on Silicon Carbide (SiC) substrates. This GaN Internally Matched (IM) FET offers excellent power added efficiency in comparison to other technologies. GaN has superior properties compared to silicon or gallium arsenide, including higher breakdown voltage, higher saturated electron drift velocity and higher thermal conductivity. GaN HEMTs also offer greater power density and wider bandwidths compared to GaAs transistors. This IM FET is available in a metal/ceramic flanged package for optimal electrical and thermal performance.



PN: CGHV96050F1 Package Type: 440210

#### Typical Performance Over 7.9-8.4 GHz (T<sub>c</sub> = 25°C)

Parameter	7.9 GHz	8.0 GHz	8.1 GHz	8.2 GHz	8.3 GHz	8.4 GHz	Units
Linear Gain	17.0	16.7	16.4	15.9	15.2	14.6	dB
Output Power	22.4	28.2	28.2	31.6	31.6	31.6	W
Power Gain	15.6	15.0	15.1	14.5	14.0	13.2	dB
Power Added Efficiency	30	37	37	39	38	37	%

Note: Measured at -30 dBc, 1.6 MHz from carrier, in the CGHV96050F1-AMP (838176) under OQPSK modulation, 1.6 Msps, PN23, Alpha Filter = 0.2

#### **Features**

- 7.9 8.4 GHz Operation
- 80 W P<sub>OUT</sub> typical
- >13 dB Power Gain
- 33 % Typical Linear PAE
- 50 Ohm Internally Matched
- <0.1 dB Power Droop</li>

#### **Applications**

- Satellite Communication
- · Terrestrial Broadband

Large Signal Models Available for ADS and MWO



### **Absolute Maximum Ratings (not simultaneous)**

Parameter	Symbol	Rating	Units	Conditions
Drain-source Voltage	V <sub>DSS</sub>	100	Volts	25°C
Gate-source Voltage	$V_{GS}$	-10, +2	Volts	25°C
Power Dissipation	P <sub>DISS</sub>	57.6 / 86.4	Watts	(CW / Pulse)
Storage Temperature	T <sub>stg</sub>	-65, +150	°C	
Operating Junction Temperature	$T_{_{\mathrm{J}}}$	225	°C	
Maximum Drain Current	I <sub>DMAX</sub>	6	Amps	
Maximum Forward Gate Current	I <sub>GMAX</sub>	14.4	mA	25°C
Soldering Temperature <sup>1</sup>	$T_s$	245	°C	
Screw Torque	τ	40	in-oz	
Thermal Resistance, Junction to Case	$R_{\scriptscriptstyle{\theta JC}}$	1.26	°C/W	Pulse Width = 100 $\mu$ s, Duty Cycle = 10%, $P_{DISS}$ = 86.4 W
Thermal Resistance, Junction to Case	$R_{\theta JC}$	2.16	°C/W	CW, 85°C, P <sub>DISS</sub> = 57.6 W
Case Operating Temperature <sup>3</sup>	T <sub>c</sub>	-40, +150	°C	

#### Note

# Electrical Characteristics (Frequency = 7.9 - 8.4 GHz unless otherwise stated; $T_c = 25^{\circ}$ C)

Characteristics	Symbol	Min.	Тур.	Max.	Units	Conditions
DC Characteristics <sup>1</sup>						
Gate Threshold Voltage	$V_{\rm GS(TH)}$	-3.8	-3.0	-2.3	V	$V_{DS} = 10 \text{ V, I}_{D} = 14.4 \text{ mA}$
Gate Quiscent Voltage	$V_{_{\mathrm{Q}}}$	-	-3.0	-	V	$V_{DS} = 40 \text{ V, } I_{D} = 500 \text{ mA}$
Saturated Drain Current <sup>2</sup>	I <sub>DS</sub>	11.5	13.0	-	Α	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$
Drain-Source Breakdown Voltage	$V_{\scriptscriptstyle BD}$	100	-	-	V	V <sub>GS</sub> = -8 V, I <sub>D</sub> = 14.4 mA
RF Characteristics <sup>3</sup>						
Small Signal Gain	S21	13.25	16	-	dB	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{IN} = -20 \text{ dBm}$
Input Return Loss	S11	-	-4.9	-3.0	dB	V <sub>DD</sub> = 40 V, I <sub>DQ</sub> = 500 mA, P <sub>IN</sub> = -20 dBm
Output Return Loss	S22	-	-10.7	-5.5	dB	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{IN} = -20 \text{ dBm}$
Power Gain <sup>3,4</sup>	P <sub>G1</sub>	10.75	15.6	-	dB	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{OUT} = 44 \text{ dBm, Freq.} = 7.9 \text{ GHz}$
Power Gain <sup>3,4</sup>	$P_{g_2}$	10.75	13.5	-	dB	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{OUT} = 44 \text{ dBm, Freq.} = 8.4 \text{ GHz}$
Power Added Efficiency <sup>3, 4</sup>	PAE <sub>1</sub>	18	25	-	%	$V_{DD} = 40 \text{ V, I}_{DQ} = 500 \text{ mA, P}_{OUT} = 44 \text{ dBm, Freq.} = 7.9 \text{ GHz}$
Power Added Efficiency <sup>3, 4</sup>	PAE <sub>2</sub>	18	27	-	%	$V_{DD}$ = 40 V, $I_{DQ}$ = 500 mA, $P_{OUT}$ = 44 dBm, Freq. = 8.4 GHz
OQPSK Linearity <sup>3,4</sup>	ACLR <sub>1</sub>	-	-	-26	dBc	$V_{DD} = 40 \text{ V, } I_{DQ} = 500 \text{ mA, } P_{OUT} = 44 \text{ dBm, Freq.} = 7.9 \text{ GHz}$
OQPSK Linearity <sup>3, 4</sup>	ACLR <sub>2</sub>	-	-	-26	dBc	$V_{DD}$ = 40 V, $I_{DQ}$ = 500 mA, $P_{OUT}$ = 44 dBm, Freq. = 8.4 GHz
Output Mismatch Stress	VSWR	-	5:1	-	Ψ	No damage at all phase angles, $V_{\rm DD}$ = 40 V, $I_{\rm DQ}$ = 500 mA

#### Notes:

<sup>&</sup>lt;sup>1</sup> Current limit for long term reliable operation.

<sup>&</sup>lt;sup>2</sup> Refer to the Application Note on soldering at http://www.cree.com/rf/document-library

 $<sup>^{\</sup>scriptscriptstyle 3}$  See also, the Power Dissipation De-rating Curve on Page 10.

<sup>&</sup>lt;sup>1</sup> Measured on-wafer prior to packaging.

<sup>&</sup>lt;sup>2</sup> Scaled from PCM data.

<sup>&</sup>lt;sup>3</sup> Measured at -30 dBc, 1.6 MHz from carrier, in the CGHV96050F1-AMP (838176) under OQPSK modulation, 1.6 Msps, PN23, Alpha: Filter = 0.2.

Fixture loss de-embedded using the following offsets: At 7.9 GHz, input and output = 0.45 dB. At 8.4 GHz, input = 0.50 dB and output = 0.55 dB.





Figure 1. - Small Signal Gain and Return Loss vs Frequency of CGHV96050F1 measured in CGHV96050F1-AMP

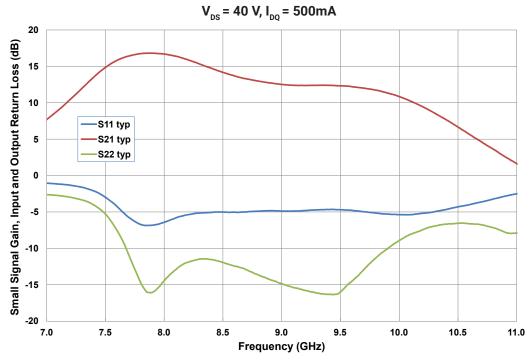
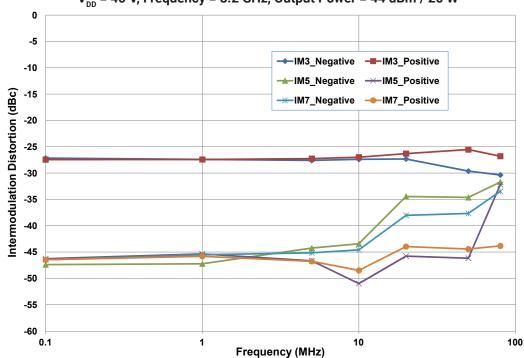


Figure 2. - Intermodulation Distortion Performance vs. Tone Spacing  $V_{\rm DD}$  = 40 V, Frequency = 8.2 GHz, Output Power = 44 dBm / 20 W

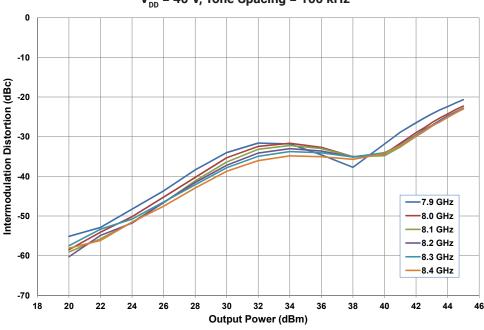




7.9 GHz\_IM3\_Negative 7.9 GHz\_IM3\_Positive 8.2 GHz\_IM3\_Negative 8.2 GHz\_IM3\_Positive -10 8.4 GHz\_IM3\_Negative 8.4 GHz\_IM3\_Positive - - 7.9 GHz\_IM5\_Positive - 7.9 GHz\_IM5\_Negative - - 8.2 GHz\_IM5\_Negative - - 8.2 GHz\_IM5\_Positive Intermodulation Distortion (dBc) - - 8.4 GHz\_IM5\_Negative - - 8.4 GHz IM5 Positive -70 -80 20 24 26 28 30 32 34 36 38 40 46 18 22 42 44 Output Power (dBm)

Figure 3. - IM3 and IM5 vs. Output Power at 7.9 GHz, 8.2 GHz, and 8.4 GHz  $V_{\tiny DD}$  = 40 V, Tone Spacing = 100 kHz



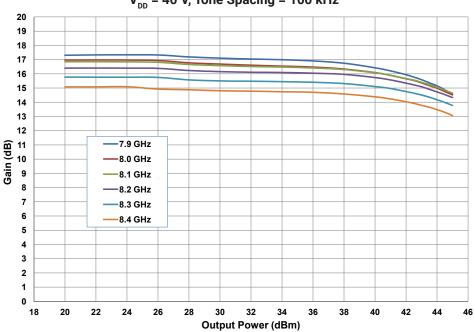




 $V_{DD} = 40 \text{ V}$ , Tone Spacing = 100 kHz 50% -7.9 GHz 45% -8.0 GHz -8.1 GHz 40% -8.2 GHz -8.3 GHz 8 35% -8.4 GHz Power Added Efficiency 30% 25% 20% 15% 10% 5% 0% 18 20 22 28 32 38 40 44 46 Output Power (dBm)

Figure 5. - Two Tone Power Added Efficiency vs. Output Power  $V_{pp} = 40 \text{ V}$ , Tone Spacing = 100 kHz







10 5 0 -7.9 GHz -5 8.2 GHz -10 8.4 GHz -15 -20 Spectra (dBc) -25 -30 -35 -40 -45 -50 -55 -60 -65 -70 -6 -3 -2 2 5 Frequency (MHz)

Figure 7. - Spectral Mask under OQPSK Modulation, 1.6 Msps  $V_{DD} = 40 \text{ V}$ , Output Power = 44 dBm / 25 W

Figure 8. - Linear Output Power, Gain, and Power Added Efficiency vs Frequency  $V_{\rm DD}$  = 40 V,  $I_{\rm DO}$  = 500 mA, 1.6 Msps, OQPSK Modulation at -30 dBc

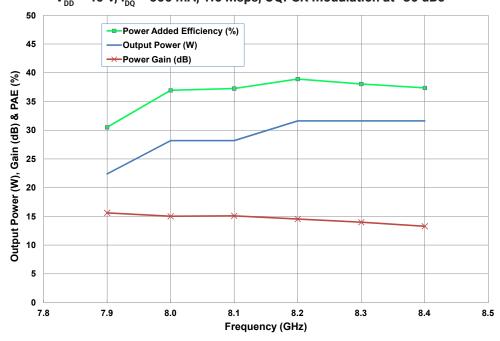




Figure 9. - OQPSK Linearity vs Output Power V<sub>DD</sub> = 40 V, Frequency = 1.6 MHz 0 -5 7.9 GHz -10 8.2 GHz 8.4 GHz Intermodulation Distortion (dBc) -15 -20 -25 -30 -35 -40 -45 -50 31 32 33 34 35 36 37 38 39 40 41 25 26 27 28 29 30 42 43 44 45

Output Power (dBm)

 $V_{DD}$  = 40 V,  $I_{DO}$  = 500 mA, 1.6 Msps, OQPSK Modulation at -30 dBc 40 Power Gain (7.9 GHz) -Power Gain (8.2 GHz) — Power Gain (8.4 GHz) Power Gain (dB). Power Added Efficiency (%) PAE (7.9 GHz) PAE (8.2 GHz) PAE (8.4 GHz) 0 31 32 34 35 36 38 39 40 41 42 44 25 26 27 28 30 33 37 43 Output Power (dBm)

Figure 10. - Power Gain and Power Added Efficiency vs Output Power

www.cree.com/rf



# **CGHV96050F1-AMP Demonstration Amplifier Circuit Bill of Materials**

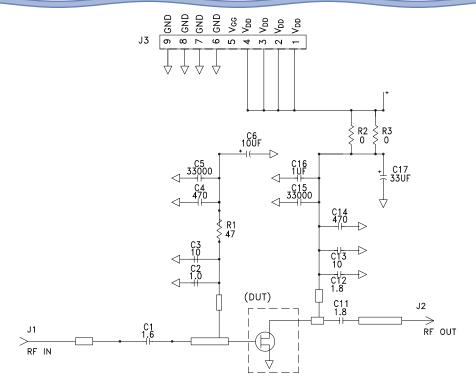
Designator	Description	Qty
R1	RES, 47 OHM,+/-1%, 1/16 W, 0603, SMD	1
R2, R3	RES, 0 OHM +/-5%, 125 mW, 1206, SMD	2
C1	CAP, 1.6pF, +/- 0.1 pF, 200V, 0402, ATC 600L	1
C2	CAP, 1.0pF, +/- 0.1 pF, 200V, 0402, ATC 600L	1
C3, C13	CAP, 10 pF +/-5%, 0603, ATC	2
C4, C14	CAP, 470 pF +/-5%, 100 V, 0603	2
C5, C15	CAP, 33,000 pF, 0805, 100 V, X7R	2
C11, C12	CAP, 1.8pF, +/- 0.1 pF, 200V, 0402, ATC 600L	2
C16	CAP, 1 uF +/-10%, 100 V, X7P, 1210	1
C17	CAP, 33 uF +/-20%, G-CASE	1
C18	CAP, 470 uF, +/-20%, ELECTROLYTIC	1
J1,J2	CONNECTOR, SMA, PANEL MOUNT JACK, FLANGE, 4-HOLE, BLUNT POST, 20MIL	2
J3	CONNECTOR, HEADER, RT>PLZ .1CEN LK 9POS	1
F	PCB, TEST FIXTURE, TACONICS RF35P, 20 MIL THK, 440210 PKG	1
-	2-56 SOC HD SCREW 1/4 SS	4
-	#2 SPLIT LOCKWASHER SS	4
Q1	CGHV96050F1	1

# **CGHV96050F1-AMP Demonstration Amplifier Circuit**

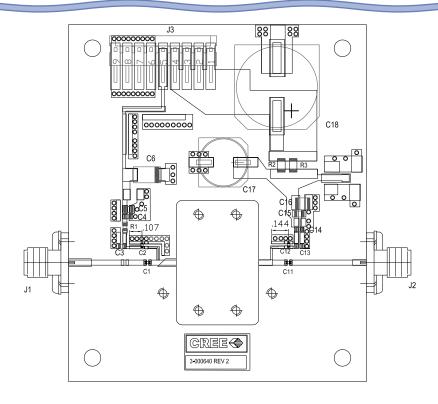




#### **CGHV96050F1-AMP Demonstration Amplifier Circuit Schematic**

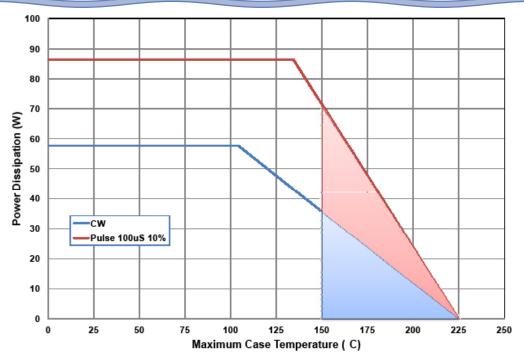


#### **CGHV96050F1-AMP Demonstration Amplifier Circuit Outline**





### **CGHV96050F1 Power Dissipation De-rating Curve**



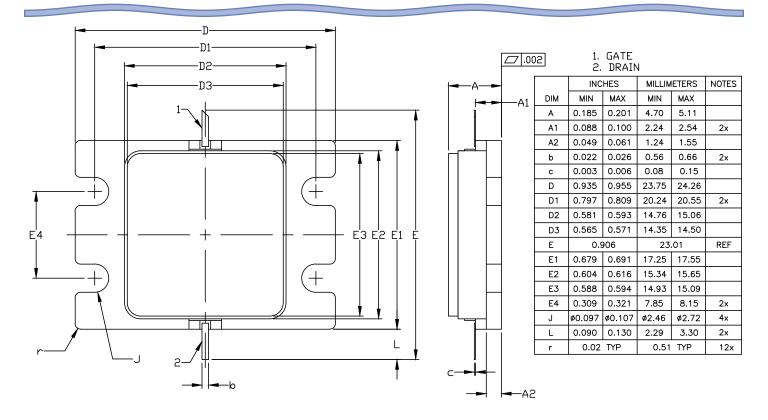
Note. Shaded area exceeds Maximum Case Operating Temperature (See Page 2)

### **Electrostatic Discharge (ESD) Classifications**

Parameter	Symbol	Class	Test Methodology
Human Body Model	НВМ	1A > 250 V	JEDEC JESD22 A114-D
Charge Device Model	CDM	1 < 200 V	JEDEC JESD22 C101-C



## Product Dimensions CGHV96050F1 (Package Type - 440210)





#### **Part Number System**



Parameter	Value	Units
Upper Frequency <sup>1</sup>	9.6	GHz
Power Output	50	W
Package	Flange	-

Table 1.

**Note**<sup>1</sup>: Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value
А	0
В	1
С	2
D	3
Е	4
F	5
G	6
Н	7
J	8
K	9
Examples:	1A = 10.0 GHz 2H = 27.0 GHz

Table 2.



## **Product Ordering Information**

Order Number	Description	Unit of Measure	lmage
CGHV96050F1	Gan HEMT	Each	CP C
CGHV96050F1-TB	Test board without GaN HEMT	Each	
CGHV96050F1-AMP	Test board with GaN HEMT installed	Each	



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